

### SN74LVC2G126-EP

ZHCSBW3-DECEMBER 2013

### 具有三态输出的双路总线缓冲器闸 查询样片: SN74LVC2G126-EP

### 特性

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- 支持 5V V<sub>CC</sub> 运行
- 输入接受的电压达到高达 5.5V
- 电压为 3.3V 时, t<sub>pd</sub> 最大值为 6.8ns
- 低功耗,最大 Icc 为 10µA
- 电压为 3.3V 时,输出驱动为 ±24mA
- V<sub>CC</sub> = 3.3V, T<sub>A</sub> = 25°C 时, V<sub>OLP</sub>(输出地弹反射)
  典型值小于 0.8V。
- V<sub>CC</sub> = 3.3V, T<sub>A</sub> = 25°C 时, V<sub>OHV</sub> (输出 V<sub>OH</sub> 下 冲) 典型值大于 2V。
- loff 支持部分断电模式工作
- 锁断性能超过 100mA(符合 JESD 78, II 类规范 的要求)
- 静电放电 (ESD) 保护性能超过 JESD 22 规范要求
  - 2000V 人体模型 (A114-A)
  - 200V 机器模型 (A115-A)
  - 1000V 充电器件模型 (C101)

### 支持国防、航空航天、和医疗应用

- 受控基线
- 同一组装和测试场所
- 一个制造场所
- 支持军用(-55°C 至 125°C)温度范围
- 延长的产品生命周期
- 延长的产品变更通知
- 产品可追溯性

DCU	封装
(顶礼	l图)

10E∏	1	8	⊥ V <sub>cc</sub>
1A 🗔	2	7	1 20E
2Y 🗔	3	6	∐ 1Y
GND 🗔	4	5	∐ 2A

### 说明

这款双路总线缓冲器闸被设计用于 1.65V 至 5.5V Vcc 运行。

SN74LVC2G126 是一款具有三态输出的双路总线驱动器/线路驱动器。当相关输出使能 (OE) 输入为低电平时,输出被禁用。

为了确保加电或断电期间的高阻抗状态, OE 应该通过一个下拉电阻器接在接地 (GND) 上;此电阻器的最小值由驱动器的电流供源能力决定。

该器件完全符合使用 loff 的部分断电应用的规范要求。 loff 电路禁用输出,从而可防止其断电时破坏性电流从该器件回流。

#### **ORDERING INFORMATION**<sup>(1)</sup>

TJ	PACKA	GE <sup>(2)</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING	VID NUMBER
–55°C to 125°C	VSSOP - DCU	Tape of 250	CLVC2G126MDCUTEP	CEPR	V62/14604-01XE

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

(2) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

### Function Table (Each Buffer)

INP	JTS	OUTPUT
OE	Α	Y
Н	Н	Н



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# Function Table (Each Buffer) (continued)

INP	UTS	OUTPUT
OE	Α	Y
Н	L	L
L	Х	Z

#### Logic Diagram (Positive Logic)



### ABSOLUTE MAXIMUM RATINGs<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage range		-0.5	6.5	V
VI	Input voltage range <sup>(2)</sup>		-0.5	6.5	V
Vo	Voltage range applied to any output in	the high-impedance or power-off state <sup>(2)</sup>	-0.5	6.5	V
Vo	Voltage range applied to any output in	the high or low state $^{(2)}$ $^{(3)}$	-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>1</sub> < 0		-50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-50	mA
Ι <sub>Ο</sub>	Continuous output current			±50	mA
	Continuous current through $V_{CC}$ or GM	ND		±100	mA
TJ	Absolute maximum junction temperature range		-55	150	°C
T <sub>stg</sub>	Storage temperature range		-65	150	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input negative-voltage and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

(3) The value of  $V_{CC}$  is provided in the recommended operating conditions table.



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### THERMAL INFORMATION

		SN74LVC2G126-EP		
	THERMAL METRIC <sup>(1)</sup>	DCU	UNITS	
		8 PINS		
$\theta_{JA}$	Junction-to-ambient thermal resistance <sup>(2)</sup>	204.3		
θ <sub>JCtop</sub>	Junction-to-case (top) thermal resistance <sup>(3)</sup>	78		
θ <sub>JB</sub>	Junction-to-board thermal resistance <sup>(4)</sup>	83	0000	
Ψյт	Junction-to-top characterization parameter <sup>(5)</sup>	7.6	°C/W	
Ψјв	Junction-to-board characterization parameter <sup>(6)</sup>	82.6		
$\theta_{JCbot}$	Junction-to-case (bottom) thermal resistance <sup>(7)</sup>	N/A		

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

(2) The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, high-K board, as specified in JESD51-7, in an environment described in JESD51-2a.

(3) The junction-to-case (top) thermal resistance is obtained by simulating a cold plate test on the package top. No specific JEDECstandard test exists, but a close description can be found in the ANSI SEMI standard G30-88.

(4) The junction-to-board thermal resistance is obtained by simulating in an environment with a ring cold plate fixture to control the PCB temperature, as described in JESD51-8.

(5) The junction-to-top characterization parameter,  $\psi_{JT}$ , estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining  $\theta_{JA}$ , using a procedure described in JESD51-2a (sections 6 and 7).

(6) The junction-to-board characterization parameter,  $\dot{\psi}_{JB}$ , estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining  $\theta_{JA}$ , using a procedure described in JESD51-2a (sections 6 and 7).

(7) The junction-to-case (bottom) thermal resistance is obtained by simulating a cold plate test on the exposed (power) pad. No specific JEDEC standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.

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NSTRUMENTS

**EXAS** 

### **RECOMMENDED OPERATING CONDITIONS**<sup>(1)</sup>

			MIN	MAX	UNIT
V	Supply voltage	Operating	1.65	5.5	V
V <sub>CC</sub>	Supply voltage	Data retention only	1.5		V
		V <sub>CC</sub> = 1.65 V to 1.95 V	0.65 × V <sub>CC</sub>		
	L Park Jacob Second configura	V <sub>CC</sub> = 2.3 V to 2.7 V	1.7		
VIH	High-level input voltage	$V_{CC} = 3 V \text{ to } 3.6 V$	2		V
		$V_{CC} = 4.5 V \text{ to } 5.5 V$	0.7 × V <sub>CC</sub>		
		V <sub>CC</sub> = 1.65 V to 1.95 V		0.35 × V <sub>CC</sub>	
	Level level formation from the	V <sub>CC</sub> = 2.3 V to 2.7 V		0.7	
V <sub>IL</sub>	Low-level input voltage	$V_{CC} = 3 V \text{ to } 3.6 V$		0.8	V
		$V_{CC} = 4.5 V \text{ to } 5.5 V$		$0.3 \times V_{CC}$	
VI	Input voltage		0	5.5	V
	Output voltage High or low state 3-state	High or low state	0 V <sub>C</sub>		V
Vo		3-state	0	5.5	V
		V <sub>CC</sub> = 1.65 V		-4	
		V <sub>CC</sub> = 2.3 V		-8	
I <sub>OH</sub>	High-level output current	<u> </u>		-16	mA
		$V_{CC} = 3 V$		-24	
		$V_{CC} = 4.5 V$		-32	
		V <sub>CC</sub> = 1.65 V		4	
		V <sub>CC</sub> = 2.3 V		8	
I <sub>OL</sub>	Low-level output current	<u> </u>		16	mA
		$V_{CC} = 3 V$		24	
		V <sub>CC</sub> = 4.5 V		32	
		$V_{CC} = 1.8 \text{ V} \pm 0.15 \text{ V}, 2.5 \text{ V} \pm 0.2 \text{ V}$		20	
Δt/Δv	Input transition rise or fall rate	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		10	ns/V
		$V_{CC} = 5 V \pm 0.5 V$		5	
TJ	Operating virtual junction temperature		-55	125	°C

(1) All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

TEXAS INSTRUMENTS

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## ELECTRICAL CHARACTERISTICS

These specifications apply for  $-55^{\circ}C \le T_1 \le 125^{\circ}C$  (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	MIN	TYP <sup>(1)</sup>	MAX	UNIT
	I <sub>OH</sub> = -100 μA	1.65 V to 5.5 V	$V_{CC} - 0.1$			
	$I_{OH} = -4 \text{ mA}$	1.65 V	1.2			
	I <sub>OH</sub> = -8 mA	2.3 V	1.9			V
V <sub>он</sub>	$I_{OH} = -16 \text{ mA}$	3 V	2.4			v
	$I_{OH} = -24 \text{ mA}$	3 V	2.3			
	$I_{OH} = -32 \text{ mA}$	4.5 V	3.8			
	I <sub>OL</sub> = 100 μA	1.65 V to 5.5 V			0.1	
	I <sub>OL</sub> = 4 mA	1.65 V			0.45	
	I <sub>OL</sub> = 8 mA	2.3 V			0.3	V
V <sub>OL</sub>	I <sub>OL</sub> = 16 mA	3 V			0.4	v
	I <sub>OL</sub> = 24 mA	3 V			0.55	
	I <sub>OL</sub> = 32 mA	4.5 V			0.55	
A or OE inputs	V <sub>I</sub> = 5.5 V or GND	0 to 5.5 V			±5	μA
off	$V_1 \text{ or } V_0 = 5.5 \text{ V}$	0			±10	μA
loz	$V_0 = 0$ to 5.5 V	3.6 V			10	μA
lcc	$V_{I} = 5.5 \text{ V or GND}, \qquad I_{O} = 0$	1.65 V to 5.5 V			10	μA
ΔI <sub>CC</sub>	One input at $V_{CC} - 0.6 V$ , Other inputs at $V_{CC}$ or GND	3 V to 5.5 V			500	μA
Data inputs				3.5		
C <sub>I</sub> Control inputs	$V_{i} = V_{CC} \text{ or } GND$	3.3 V		4		pF
Co	$V_{O} = V_{CC} \text{ or } GND$	3.3 V		6.5		pF

(1) All typical values are at V<sub>CC</sub> = 3.3 V, T<sub>J</sub> = 25°C.

### SWITCHING CHARACTERISTICS

These specifications apply for  $-55^{\circ}C \le T_{J} \le 125^{\circ}C$  (unless otherwise noted) (see Figure 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 1 ± 0.1		V <sub>CC</sub> = 2 ± 0.2		V <sub>CC</sub> = 3 ± 0.3		V <sub>CC</sub> = ± 0.5		UNIT
	(INPUT)	(001F01)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t <sub>pd</sub>	А	Y	3.5	15.2	1.7	8.6	1.4	6.8	1	5.5	ns
t <sub>en</sub>	OE	Y	3.5	15.2	1.7	8.6	1.5	6.8	1	5.5	ns
t <sub>dis</sub>	OE	Y	1.7	12.6	1	5.7	1	4.5	0.1	3.3	ns

### **OPERATING CHARACTERISTICS**

 $T_J = 25^{\circ}$ 

PARAMETER		TEST	V <sub>CC</sub> = 1.8 V	$V_{CC}$ = 2.5 V	V <sub>CC</sub> = 3.3 V	$V_{CC} = 5 V$	UNIT	
		•	CONDITIONS	TYP	TYP	TYP	TYP	ÖNIT
<u> </u>	Power dissipation	Outputs enabled	f 10 MU	19	19	20	22	۶L
C <sub>pd</sub>	capacitance	Outputs disabled	f = 10 MHz	2	2	2	3	pF



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- (1) See datasheet for absolute maximum and minimum recommended operating conditions.
- (2) Silicon operating life design goal is 10 years at 105°C junction temperature (does not include package interconnect life).
- (3) Enhanced plastic product disclaimer applies.

### Figure 1. SN74LVC2G126-EP Operating Life Derating Chart

### SN74LVC2G126-EP

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V

0 V

V.

0 V

V,

0 V

 $V_{LOAD}/2$ 

 $V_{OL}$ 

V<sub>oh</sub>

≈0 V

V<sub>M</sub>



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Input

Output

Output

t<sub>PHL</sub>

#### PARAMETER MEASUREMENT INFORMATION



TEST	S1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
$t_{PLZ}/t_{PZL}$	VLOAD
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

Vм

t.

V<sub>M</sub>

LOW- AND HIGH-LEVEL ENABLING

- t<sub>PLZ</sub>

t<sub>PH7</sub>

t<sub>su</sub>

V <sub>cc</sub>	INF	PUTS	- V <sub>M</sub>	V	•		N
	V,	t,/t,		VLOAD	CL	R	V
1.8 V ± 0.15 V	V <sub>cc</sub>	≤2 ns	V <sub>cc</sub> /2	2 × V <sub>cc</sub>	30 pF	<b>1 k</b> Ω	0.15 V
$2.5~V\pm0.2~V$	V <sub>cc</sub>	≤2 ns	V <sub>cc</sub> /2	2 × V <sub>cc</sub>	30 pF	<b>500</b> Ω	0.15 V
$3.3 V \pm 0.3 V$	3 V	≤2.5 ns	1.5 V	6 V	50 pF	<b>500</b> Ω	0.3 V
$5 V \pm 0.5 V$	V <sub>cc</sub>	≤2.5 ns	V <sub>cc</sub> /2	2 × V <sub>cc</sub>	50 pF	<b>500</b> Ω	0.3 V

**Timing Input** 





INVERTING AND NONINVERTING OUTPUTS

NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control. C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>0</sub> = 50  $\Omega$ .
- D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F.  $t_{\mbox{\tiny PZL}}$  and  $t_{\mbox{\tiny PZH}}$  are the same as  $t_{\mbox{\tiny en}}.$
- G.  $t_{\mbox{\tiny PLH}}$  and  $t_{\mbox{\tiny PHL}}$  are the same as  $t_{\mbox{\tiny pd}}$
- H. All parameters and waveforms are not applicable to all devices.

#### Figure 2. Load Circuit and Voltage Waveforms



10-Dec-2020

### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CLVC2G126MDCUTEP	ACTIVE	VSSOP	DCU	8	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CEPR	Samples
V62/14604-01XE	ACTIVE	VSSOP	DCU	8	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CEPR	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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### PACKAGE OPTION ADDENDUM

10-Dec-2020

DCU (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE (DIE DOWN)



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.

D. Falls within JEDEC MO-187 variation CA.





- NOTES: A. All linear dimensions are in millimeters. В. This drawing is subject to change without notice.
  - C. Publication IPC-7351 is recommended for alternate designs.
  - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
  - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



#### 重要声明和免责声明

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